

# PCA9519 4-channel level translating I<sup>2</sup>C-bus/SMBus repeater Rev. 01 – 22 June 2006 Objective data sheet

# 1. General description

The PCA9519 is a 4-channel level translating I<sup>2</sup>C-bus/SMBus repeater that enables the processor low voltage 2-wire serial bus to interface with standard I<sup>2</sup>C-bus or SMBus I/O. While retaining all the operating modes and features of the I<sup>2</sup>C-bus system during the level shifts, it also permits extension of the I<sup>2</sup>C-bus by providing bidirectional buffering for both the data (SDA) and the clock (SCL) lines, thus enabling the I<sup>2</sup>C-bus or SMBus maximum capacitance of 400 pF on the higher voltage side. The SDA and SCL pins are over-voltage tolerant and are high-impedance when the PCA9519 is unpowered.

The port B drivers are compliant with SMBus I/O levels, while port A uses a current sensing mechanism to detect the input or output LOW signal which prevents bus lock-up. The port A uses a 1 mA current source for pull-up and a 200  $\Omega$  pull-down driver. This results in a LOW on port A accommodating smaller voltage swings. The output pull-down on the port A internal buffer LOW is set for approximately 0.2 V, while the input threshold of the internal buffer is set about 50 mV lower than that of the output voltage LOW. When the port A I/O is driven LOW internally, the LOW is not recognized as a LOW by the input. This prevents a lock-up condition from occurring. The output pull-down on the port B drives a hard LOW and the input level is set at 0.3 of SMBus or I<sup>2</sup>C-bus voltage level which enables port B to connect to any other I<sup>2</sup>C-bus device or buffer.

The PCA9519 drivers are not enabled unless V<sub>CC(A)</sub> is above 0.8 V and V<sub>CC(B)</sub> is above 2.5 V. The enable (EN) pin can also be used to turn the drivers on and off under system control. Caution should be observed to only change the state of the EN pin when the bus is idle.

# 2. Features

- 4-channel (4 SCL/SDA pairs), bidirectional buffer isolates capacitance and allows 400 pF on port B of the device
- Voltage level translation from port A (1 V to V<sub>CC(B)</sub> 1 V) to port B (3.0 V to 5.5 V)
- Requires no external pull-up resistors on lower voltage port A
- Active HIGH repeater enable input
- Open-drain inputs/outputs
- Lock-up free operation
- Supports arbitration and clock stretching across the repeater
- Accommodates Standard-mode and Fast-mode I<sup>2</sup>C-bus devices and multiple masters
- Powered-off high-impedance I<sup>2</sup>C-bus pins
- Operating supply voltage range of 1.0 V to V<sub>CC(B)</sub> 1 V on port A, 3.0 V to 5.5 V on port B
- 5 V tolerant B-side SCL and SDA and enable pins

# PHILIPS

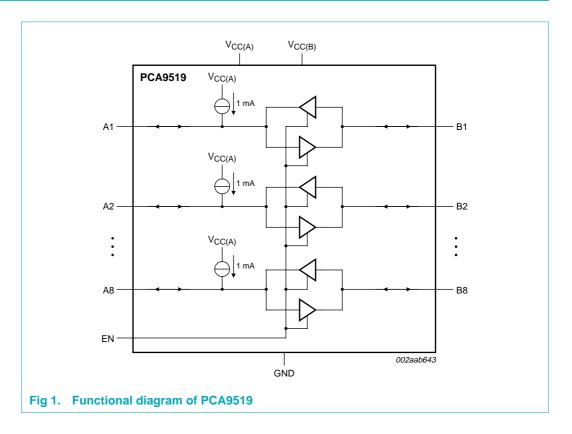
- 0 Hz to 400 kHz clock frequency
   Remark: The maximum system operating frequency may be less than 400 kHz because of the delays added by the repeater.
- ESD protection exceeds 2000 V HBM per JESD22-A114, 200 V MM per JESD22-A115, and 1000 V CDM per JESD22-C101
- Latch-up testing is done to JEDEC Standard JESD78 which exceeds 100 mA
- Packages offered: TSSOP20, HVQFN24

# 3. Ordering information

Table 1.	Ordering information
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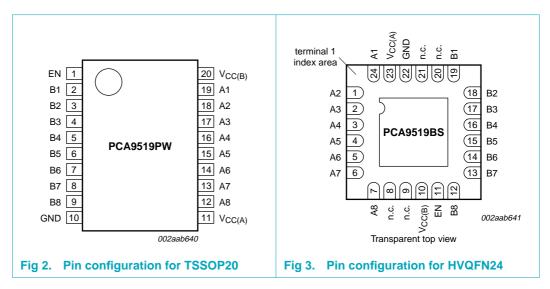
Type number Topside		Package	Package				
	mark	Name	Description	Version			
PCA9519PW	PCA9519	TSSOP20	plastic thin shrink small outline package; 20 leads; body width 4.4 mm	SOT360-1			
PCA9519BS	9519	HVQFN24	plastic thermal enhanced very thin quad flat package; no leads; 24 terminals; body $4 \times 4 \times 0.85$ mm	SOT616-1			

# 4. Functional diagram



# 5. Pinning information

# 5.1 Pinning



# 5.2 Pin description

Table 2. F	Table 2. Pin description			
Symbol	Pin		Description	
	TSSOP20	HVQFN24		
EN	1	11	enable input (active HIGH)	
GND	10	22 <mark>[1]</mark>	ground (0 V)	
V <sub>CC(A)</sub>	11	23	port A power supply	
A1	19	24	A1 port (low voltage side) <sup>[2]</sup>	
A2	18	1	A2 port (low voltage side) <sup>[2]</sup>	
A3	17	2	A3 port (low voltage side) <sup>[2]</sup>	
A4	16	3	A4 port (low voltage side) <sup>[2]</sup>	
A5	15	4	A5 port (low voltage side) <sup>[2]</sup>	
A6	14	5	A6 port (low voltage side) <sup>[2]</sup>	
A7	13	6	A7 port (low voltage side) <sup>[2]</sup>	
A8	12	7	A8 port (low voltage side) <sup>[2]</sup>	
V <sub>CC(B)</sub>	20	10	port B power supply	
B8	9	12	B8 port (SMBus/I <sup>2</sup> C-bus side) <sup>[2]</sup>	
B7	8	13	B7 port (SMBus/I <sup>2</sup> C-bus side) <sup>[2]</sup>	
B6	7	14	B6 port (SMBus/I <sup>2</sup> C-bus side) <sup>[2]</sup>	
B5	6	15	B5 port (SMBus/I <sup>2</sup> C-bus side) <sup>[2]</sup>	
B4	5	16	B4 port (SMBus/I <sup>2</sup> C-bus side) <sup>[2]</sup>	
B3	4	17	B3 port (SMBus/I <sup>2</sup> C-bus side) <sup>[2]</sup>	

Table 2.         Pin descriptioncontinued				
Symbol	Pin TSSOP20 HVQFN24		Description	
B2	3	18	B2 port (SMBus/I <sup>2</sup> C-bus side) <sup>[2]</sup>	
B1	2	19	B1 port (SMBus/I <sup>2</sup> C-bus side) <sup>[2]</sup>	
n.c.	-	8, 9, 20, 21	not connected	

[1] HVQFN package die supply ground is connected to both the GND pin and the exposed center pad. The GND pin must be connected to supply ground for proper device operation. For enhanced thermal, electrical, and board-level performance, the exposed pad needs to be soldered to the board using a corresponding thermal pad on the board, and for proper heat conduction through the board thermal vias need to be incorporated in the PCB in the thermal pad region.

[2] Port A and port B can be used for either SCL or SDA.

# 6. Functional description

Refer to Figure 1 "Functional diagram of PCA9519".

The PCA9519 enables l<sup>2</sup>C-bus or SMBus translation down to V<sub>CC(A)</sub> as low as 1.0 V without degradation of system performance. The PCA9519 contains 8 bidirectional open-drain buffers specifically designed to support up-translation/down-translation between the low voltage and 3.3 V SMBus or 5 V l<sup>2</sup>C-bus. Port B I/Os are over-voltage tolerant to 5.5 V even when the device is unpowered.

The PCA9519 includes a power-up circuit that keeps the output drivers turned off until  $V_{CC(B)}$  is above 2.5 V and the  $V_{CC(A)}$  is above 0.8 V.  $V_{CC(B)}$  and  $V_{CC(A)}$  can be applied in any sequence at power-up. After power-up and with the EN pin HIGH, a LOW level on the port A (below approximately 0.15 V) turns the corresponding port B driver (either SDA or SCL) on and drives the port B down to about 0 V. When port A rises above approximately 0.15 V, the port B pull-down driver is turned off and the external pull-up resistor pulls the pin HIGH. When the port B falls first and goes below  $0.3V_{CC(B)}$ , the port A driver is turned on and the port A pulls down to 0.2 V (typical). The port B pull-down is not enabled unless the port A voltage goes below  $V_{ILc}$ . If the port A low voltage goes below  $V_{ILc}$ , the port B pull-down driver is enabled until the port A rises above approximately 0.15 V ( $V_{ILc}$ ), then the port B, if not externally driven LOW, will continue to rise being pulled up by the external pull-up resistor.

**Remark:** Ground offset between the PCA9519 ground and the ground of devices on port A of the PCA9519 must be avoided.

The reason for this cautionary remark is that a CMOS/NMOS open-drain capable of sinking 3 mA of current at 0.4 V will have an output resistance of 133  $\Omega$  or less (R = E / I). Such a driver will share enough current with the port A output pull-down of the PCA9519 to be seen as a LOW as long as the ground offset is zero. If the ground offset is greater than 0 V, then the driver resistance must be less. Since V<sub>ILc</sub> can be as low as 90 mV at cold temperatures and the low end of the current distribution, the maximum ground offset should not exceed 50 mV.

Bus repeaters that use an output offset are not interoperable with port A of the PCA9519 as their output LOW levels will not be recognized by the PCA9519 as a LOW. If the PCA9519 is placed in an application where the  $V_{IL}$  of the port A of the PCA9519 does not

go below its  $V_{ILc}$  it will pull the port B LOW initially when the port A input transitions LOW but port B will return HIGH, so it will not reproduce the port A input on port B. Such applications should be avoided.

Port B is interoperable with all I<sup>2</sup>C-bus slaves, masters, and repeaters.

### 6.1 Enable

The EN pin is active HIGH and allows the user to select when the repeater is active. This can be used to isolate a badly behaved slave on power-up until after the system power-up reset. It should never change state during an  $I^2C$ -bus operation because disabling during a bus operation will hang the bus and enabling part way through a bus cycle could confuse the  $I^2C$ -bus parts being enabled.

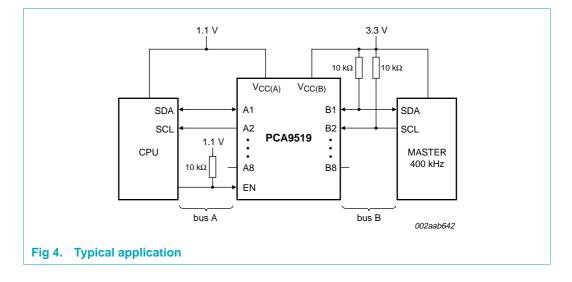
The enable pin should only change state when the bus and the repeater port are in an idle state to prevent system failures.

## 6.2 I<sup>2</sup>C-bus systems

As with the standard I<sup>2</sup>C-bus system, pull-up resistors are required to provide the logic HIGH levels on the buffered bus (standard open-collector configuration of the I<sup>2</sup>C-bus). The size of these pull-up resistors depends on the system. Each of the port A I/Os has an internal pull-up current source and does not require the external pull-up resistor. The port B is designed to work with Standard mode and Fast mode I<sup>2</sup>C-bus devices in addition to SMBus devices. Standard mode I<sup>2</sup>C-bus devices only specify 3 mA output drive; this limits the termination current to 3 mA in a generic I<sup>2</sup>C-bus system where Standard mode devices and multiple masters are possible. Under certain conditions higher termination currents can be used.

# 7. Application design-in information

A typical application is shown in Figure 4. In this example, the CPU is running on a 1.1 V  $I^{2}$ C-bus while the master is connected to a 3.3 V bus. Both buses run at 400 kHz. Master devices can be placed on either bus.



### 4-channel level translating I<sup>2</sup>C-bus/SMBus repeater

When port B of the PCA9519 is pulled LOW by a driver on the I<sup>2</sup>C-bus, a CMOS hysteresis detects the falling edge when it goes below  $0.3V_{CC(B)}$  and causes the internal driver on port A to turn on, causing port A to pull down to about 0.2 V. When port A of the PCA9519 falls, first a comparator detects the falling edge and causes the internal driver on port B to turn on and pull the port B pin down to ground. In order to illustrate what would be seen in a typical application, refer to Figure 5 and Figure 6. If the bus master in Figure 4 were to write to the slave through the PCA9519, waveforms shown in Figure 5 would be observed on the B bus. This looks like a normal I<sup>2</sup>C-bus transmission.

On the port A bus of the PCA9519, the clock and data lines would have a positive offset from ground equal to the V<sub>OL</sub> of the PCA9519. After the 8<sup>th</sup> clock pulse, the data line will be pulled to the V<sub>OL</sub> of the master device, which is very close to ground in this example. At the end of the acknowledge, the level rises only to the LOW level set by the driver in the PCA9519 for a short delay while the port B bus rises above  $0.5V_{CC(B)}$ , then it continues HIGH. It is important to note that any arbitration or clock stretching events require that the LOW level on the port A bus at the input of the PCA9519 (V<sub>IL</sub>) is below V<sub>ILc</sub> to be recognized by the PCA9519 and then transmitted to the port B bus.

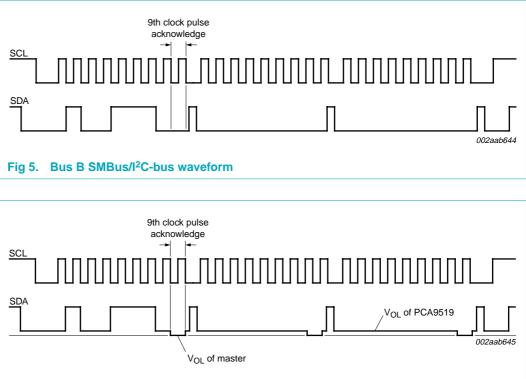


Fig 6. Bus A lower voltage waveform

# 8. Limiting values

#### Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC(B)</sub>	supply voltage port B		-0.5	+6	V
V <sub>CC(A)</sub>	supply voltage port A		-0.5	+6	V
V <sub>I/O</sub>	voltage on an input/output pin	port A	-0.5	+6	V
		port B; enable pin (EN)	-0.5	+6	V
I <sub>I/O</sub>	input/output current		-	±20	mA
l <sub>l</sub>	input current		-	±20	mA
P <sub>tot</sub>	total power dissipation		-	100	mW
T <sub>stg</sub>	storage temperature		-65	+150	°C
T <sub>amb</sub>	ambient temperature	operating in free air	-40	+85	°C
Tj	junction temperature		-	125	°C
T <sub>sp</sub>	solder point temperature	10 s max.	-	300	°C

# 9. Static characteristics

#### Table 4.Static characteristics

GND = 0 V;  $T_{amb} = -40 \circ C$  to +85  $\circ C$ ; unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ <mark>[1]</mark>	Max	Unit
Supplies							
V <sub>CC(B)</sub>	supply voltage port B			3.0	-	5.5	V
V <sub>CC(A)</sub>	supply voltage port A			1.0	-	$V_{CC(B)} - 1$	V
I <sub>CC(A)</sub>	supply current port A	all port A static HIGH		1	2.1	3.6	mA
		all port A static LOW		5	11.6	20	mA
I <sub>CC(B)</sub>	supply current port B	all port B static HIGH		2	3.3	4.5	mA
Input and	output of port A (A1 to A8)						
V <sub>IH</sub>	HIGH-level input voltage	port A		$0.7V_{CC(A)}$	-	V <sub>CC(A)</sub>	V
V <sub>IL</sub>	LOW-level input voltage	port A	[2]	-0.5	-	+0.3	V
V <sub>ILc</sub>	contention LOW-level input voltage		[2]	-0.5	+0.15	-	V
V <sub>IK</sub>	input clamping voltage	$I_{L} = -18 \text{ mA}$		-1.5	-	-0.5	V
ILI	input leakage current	$V_I = V_{CC(A)}$		-	-	±1	μΑ
I <sub>IL</sub>	LOW-level input current		[3]	-1.5	-1	-0.45	mA
V <sub>OL</sub>	LOW-level output voltage		[4]	-	0.2	0.35	V
V <sub>OL</sub> –V <sub>ILc</sub>	difference between LOW-level output and LOW-level input voltage contention	port A	[5]	-	50	-	mV
I <sub>LOH</sub>	HIGH-level output leakage current	V <sub>O</sub> = 1.1 V		-	-	10	μΑ
C <sub>io</sub>	input/output capacitance			-	6	7	pF

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### 4-channel level translating I<sup>2</sup>C-bus/SMBus repeater

Symbol	Parameter	Conditions	Min	Typ <mark>[1]</mark>	Max	Unit
Input and	output of port B (B1 to B8)					
V <sub>IH</sub>	HIGH-level input voltage		0.7V <sub>CC(B)</sub>	-	V <sub>CC(B)</sub>	V
V <sub>IL</sub>	LOW-level input voltage		-0.5	-	+0.3V <sub>CC(B)</sub>	V
V <sub>IK</sub>	input clamping voltage	$I_{L} = -18 \text{ mA}$	-1.5	-	-0.5	V
I <sub>LI</sub>	input leakage current	V <sub>I</sub> = 3.6 V	-1.0	-	+1.0	μΑ
I <sub>IL</sub>	LOW-level input current	V <sub>I</sub> = 0.2 V	-	-	10	μΑ
V <sub>OL</sub>	LOW-level output voltage	$I_{OL} = 6 \text{ mA}$	-	0.1	0.2	V
I <sub>LOH</sub>	HIGH-level output leakage current	V <sub>O</sub> = 3.6 V	-	-	10	μΑ
C <sub>io</sub>	input/output capacitance		-	6	7	pF
Enable						
V <sub>IL</sub>	LOW-level input voltage		-0.5	-	0.1V <sub>CC(A)</sub>	V
V <sub>IH</sub>	HIGH-level input voltage		$0.9V_{CC(A)}$	-	V <sub>CC(B)</sub>	V
I <sub>IL(EN)</sub>	LOW-level input current on pin EN	V <sub>I</sub> = 0.2 V, EN; V <sub>CC</sub> = 3.6 V	-1	-	+1	μA
I <sub>LI</sub>	input leakage current		-1	-	+1	μA
Ci	input capacitance	$V_{I} = 3.0 \text{ V or } 0 \text{ V}$	-	2	3	рF

#### Static characteristics ... continued Table 4.

. ..

[1] Typical values with  $V_{CC(A)} = 1.1 \text{ V}, V_{CC(B)} = 5.0 \text{ V}.$ 

[2] V<sub>IL</sub> specification is for the falling edge seen by the port A input. V<sub>ILc</sub> is for the static LOW levels seen by the port A input resulting in port B output staying LOW.

The port A current source has a typical value of about 1 mA, but varies with both V<sub>CC(A)</sub> and V<sub>CC(B)</sub>. Below V<sub>CC(A)</sub> of about 0.7 V the [3] port A current source current drops to 0 mA. The current source current dropping across the internal pull-down driver resistance of about 200  $\Omega$  defines the V<sub>OL</sub>.

[4] As long as the chip ground is common with the input ground reference the driver resistance may be as large as 120 Ω. However, ground offset will rapidly decrease the maximum allowed driver resistance.

[5] Guaranteed by design.

# **10. Dynamic characteristics**

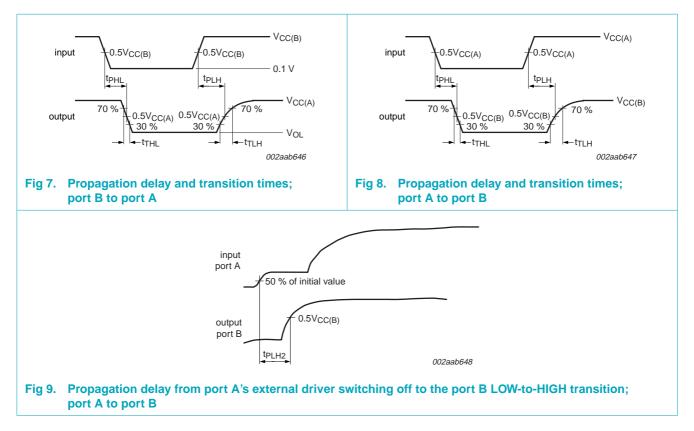
Table 5.	Dynamic characteristics						
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$V_{CC(A)} = 1$	.1 V; V <sub>CC(B)</sub> = 3.3 V						
t <sub>PLH</sub>	LOW-to-HIGH propagation delay	port B to port A	<u>[1]</u>	69	109	216	ns
t <sub>PHL</sub>	HIGH-to-LOW propagation delay	port B to port A	<u>[1]</u>	63	86	140	ns
t <sub>TLH</sub>	LOW to HIGH output transition time	port A	<u>[1]</u>	14	22	96	ns
t <sub>THL</sub>	HIGH to LOW output transition time	port A	<u>[1]</u>	5	8.1	16	ns
t <sub>PLH</sub>	LOW-to-HIGH propagation delay	port A to port B	<u>[1]</u>	-69	-91	-139	ns
t <sub>PLH2</sub>	LOW to HIGH propagation delay 2	port A to port B; measured from the 50 % of initial LOW on port A to 1.5 V rising on port B	<u>[1]</u>	91	153	226	ns
t <sub>PHL</sub>	HIGH-to-LOW propagation delay	port A to port B	<u>[1]</u>	73	122	183	ns
t <sub>TLH</sub>	LOW to HIGH output transition time	port B	[1][2]	-	61	-	ns
t <sub>THL</sub>	HIGH to LOW output transition time	port B	<u>[1]</u>	15	24	40	ns
t <sub>su</sub>	setup time	EN HIGH before START condition		100	-	-	ns
t <sub>h</sub>	hold time	EN HIGH after STOP condition		100	-	-	ns
$V_{CC(A)} = 1$	.9 V; V <sub>CC(B)</sub> = 5.0 V						
t <sub>PLH</sub>	LOW-to-HIGH propagation delay	port B to port A	<u>[1]</u>	69	105	216	ns
t <sub>PHL</sub>	HIGH-to-LOW propagation delay	port B to port A	<u>[1]</u>	63	86	140	ns
t <sub>TLH</sub>	LOW to HIGH output transition time	port A	<u>[1]</u>	14	27	96	ns
t <sub>THL</sub>	HIGH to LOW output transition time	port A	<u>[1]</u>	5	8	35	ns
t <sub>PLH</sub>	LOW-to-HIGH propagation delay	port A to port B	<u>[1]</u>	-69	-89	-139	ns
t <sub>PLH2</sub>	LOW to HIGH propagation delay 2	port A to port B; measured from the 50 % of initial LOW on port A to 1.5 V rising on port B	<u>[1]</u>	91	131	226	ns
t <sub>PHL</sub>	HIGH-to-LOW propagation delay	port A to port B	<u>[1]</u>	73	99	183	ns
t <sub>TLH</sub>	LOW to HIGH output transition time	port B	[1][2]	-	65	-	ns
t <sub>THL</sub>	HIGH to LOW output transition time	port B	<u>[1]</u>	15	31	40	ns
t <sub>su</sub>	setup time	EN HIGH before START condition		100	-	-	ns
t <sub>h</sub>	hold time	EN HIGH after STOP condition		100	-	-	ns

[1] Load capacitance = 50 pF; load resistance on port B = 1.35 k $\Omega$ .

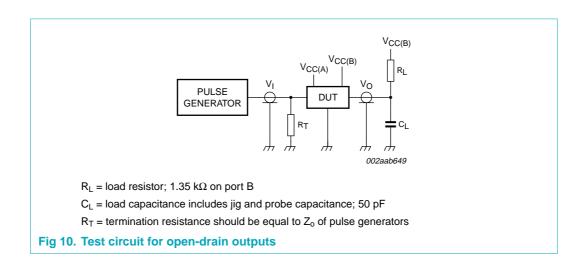
[2] Value is determined by RC time constant of bus line.

### 4-channel level translating I<sup>2</sup>C-bus/SMBus repeater

## 10.1 AC waveforms



# **11. Test information**

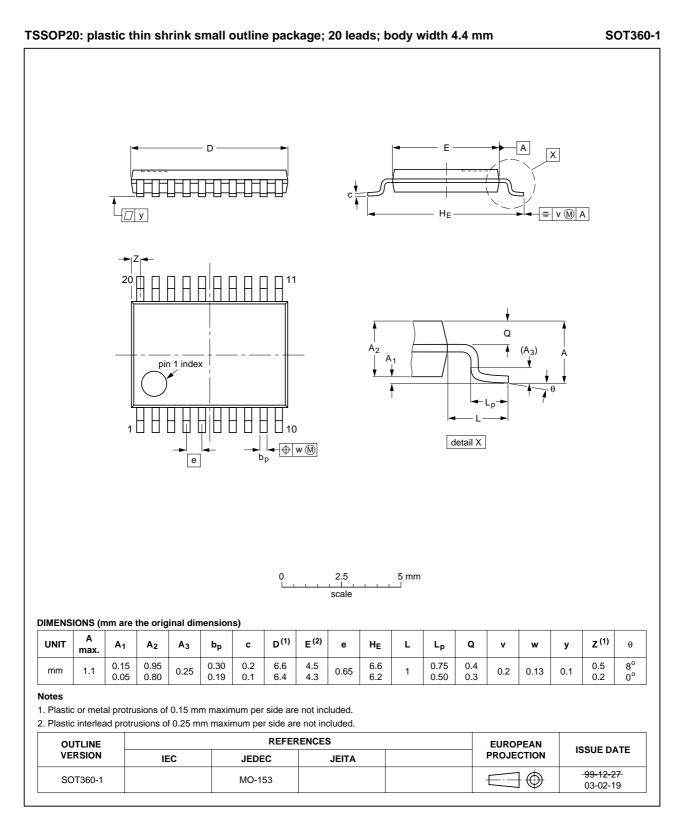


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# PCA9519

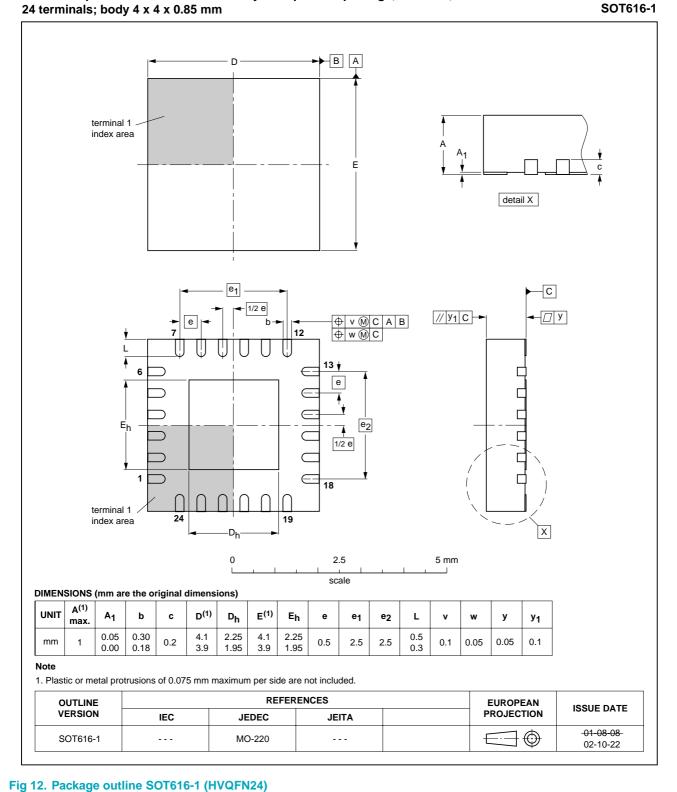
4-channel level translating l<sup>2</sup>C-bus/SMBus repeater

# 12. Package outline



# Fig 11. Package outline SOT360-1 (TSSOP20) PCA9519\_1

### 4-channel level translating I<sup>2</sup>C-bus/SMBus repeater



#### HVQFN24: plastic thermal enhanced very thin quad flat package; no leads; 24 terminals; body 4 x 4 x 0.85 mm

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PCA9519\_1

# 13. Soldering

### **13.1** Introduction to soldering surface mount packages

There is no soldering method that is ideal for all surface mount IC packages. Wave soldering can still be used for certain surface mount ICs, but it is not suitable for fine pitch SMDs. In these situations reflow soldering is recommended.

### 13.2 Reflow soldering

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement. Driven by legislation and environmental forces the worldwide use of lead-free solder pastes is increasing.

Several methods exist for reflowing; for example, convection or convection/infrared heating in a conveyor type oven. Throughput times (preheating, soldering and cooling) vary between 100 seconds and 200 seconds depending on heating method.

Typical reflow temperatures range from 215 °C to 260 °C depending on solder paste material. The peak top-surface temperature of the packages should be kept below:

Table 6.SnPb eutectic process - package peak reflow temperatures (from *J-STD-020C*<br/>July 2004)

Package thickness	Volume mm <sup>3</sup> < 350	Volume $mm^3 \ge 350$
< 2.5 mm	240 °C + 0/–5 °C	225 °C + 0/–5 °C
≥ 2.5 mm	225 °C + 0/–5 °C	225 °C + 0/–5 °C

# Table 7.Pb-free process - package peak reflow temperatures (from J-STD-020C July<br/>2004)

/			
Package thickness	Volume mm <sup>3</sup> < 350	Volume mm <sup>3</sup> 350 to 2000	Volume mm <sup>3</sup> > 2000
< 1.6 mm	260 °C + 0 °C	260 °C + 0 °C	260 °C + 0 °C
1.6 mm to 2.5 mm	260 °C + 0 °C	250 °C + 0 °C	245 °C + 0 °C
$\geq$ 2.5 mm	250 °C + 0 °C	245 °C + 0 °C	245 °C + 0 °C

Moisture sensitivity precautions, as indicated on packing, must be respected at all times.

### 13.3 Wave soldering

Conventional single wave soldering is not recommended for surface mount devices (SMDs) or printed-circuit boards with a high component density, as solder bridging and non-wetting can present major problems.

To overcome these problems the double-wave soldering method was specifically developed.

If wave soldering is used the following conditions must be observed for optimal results:

- Use a double-wave soldering method comprising a turbulent wave with high upward pressure followed by a smooth laminar wave.
- For packages with leads on two sides and a pitch (e):

- larger than or equal to 1.27 mm, the footprint longitudinal axis is preferred to be parallel to the transport direction of the printed-circuit board;
- smaller than 1.27 mm, the footprint longitudinal axis **must** be parallel to the transport direction of the printed-circuit board.

The footprint must incorporate solder thieves at the downstream end.

• For packages with leads on four sides, the footprint must be placed at a 45° angle to the transport direction of the printed-circuit board. The footprint must incorporate solder thieves downstream and at the side corners.

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Typical dwell time of the leads in the wave ranges from 3 seconds to 4 seconds at 250 °C or 265 °C, depending on solder material applied, SnPb or Pb-free respectively.

A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

### 13.4 Manual soldering

Fix the component by first soldering two diagonally-opposite end leads. Use a low voltage (24 V or less) soldering iron applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to 300  $^{\circ}$ C.

When using a dedicated tool, all other leads can be soldered in one operation within 2 seconds to 5 seconds between 270  $^\circ C$  and 320  $^\circ C.$ 

### 13.5 Package related soldering information

 Table 8.
 Suitability of surface mount IC packages for wave and reflow soldering methods

Package <sup>[1]</sup>	Soldering method				
	Wave	Reflow <sup>[2]</sup>			
BGA, HTSSONT <sup>[3]</sup> , LBGA, LFBGA, SQFP, SSOPT <sup>[3]</sup> , TFBGA, VFBGA, XSON	not suitable	suitable			
DHVQFN, HBCC, HBGA, HLQFP, HSO, HSOP, HSQFP, HSSON, HTQFP, HTSSOP, HVQFN, HVSON, SMS	not suitable <sup>[4]</sup>	suitable			
PLCC <sup>[5]</sup> , SO, SOJ	suitable	suitable			
LQFP, QFP, TQFP	not recommended <sup>[5][6]</sup>	suitable			
SSOP, TSSOP, VSO, VSSOP	not recommended <sup>[7]</sup>	suitable			
CWQCCNL <sup>[8]</sup> , PMFP <sup>[9]</sup> , WQCCNL <sup>[8]</sup>	not suitable	not suitable			

 For more detailed information on the BGA packages refer to the (LF)BGA Application Note (AN01026); order a copy from your Philips Semiconductors sales office.

[2] All surface mount (SMD) packages are moisture sensitive. Depending upon the moisture content, the maximum temperature (with respect to time) and body size of the package, there is a risk that internal or external package cracks may occur due to vaporization of the moisture in them (the so called popcorn effect). For details, refer to the Drypack information in the Data Handbook IC26; Integrated Circuit Packages; Section: Packing Methods.

- [3] These transparent plastic packages are extremely sensitive to reflow soldering conditions and must on no account be processed through more than one soldering cycle or subjected to infrared reflow soldering with peak temperature exceeding 217 °C ± 10 °C measured in the atmosphere of the reflow oven. The package body peak temperature must be kept as low as possible.
- [4] These packages are not suitable for wave soldering. On versions with the heatsink on the bottom side, the solder cannot penetrate between the printed-circuit board and the heatsink. On versions with the heatsink on the top side, the solder might be deposited on the heatsink surface.
- [5] If wave soldering is considered, then the package must be placed at a 45° angle to the solder wave direction. The package footprint must incorporate solder thieves downstream and at the side corners.
- [6] Wave soldering is suitable for LQFP, QFP and TQFP packages with a pitch (e) larger than 0.8 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.65 mm.
- [7] Wave soldering is suitable for SSOP, TSSOP, VSO and VSSOP packages with a pitch (e) equal to or larger than 0.65 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.5 mm.
- [8] Image sensor packages in principle should not be soldered. They are mounted in sockets or delivered pre-mounted on flex foil. However, the image sensor package can be mounted by the client on a flex foil by using a hot bar soldering process. The appropriate soldering profile can be provided on request.
- [9] Hot bar soldering or manual soldering is suitable for PMFP packages.

# **14. Abbreviations**

Table 9.	Abbreviations
Acronym	Description
CDM	Charged Device Model
CMOS	Complementary Metal Oxide Semiconductor
CPU	Central Processing Unit
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
I/O	Input/Output
I <sup>2</sup> C-bus	Inter-Integrated Circuit Bus
MM	Machine Model
NMOS	Negative-channel Metal Oxide Semiconductor
RC	Resistor Capacitor network
SMBus	System Management Bus

# **15. Revision history**

Table 10. Revision histo	ory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
PCA9519_1	20060622	Objective data sheet	-	-

# **16. Legal information**

### **16.1 Data sheet status**

Document status[1][2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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## 4-channel level translating I<sup>2</sup>C-bus/SMBus repeater

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